


<b>Search Notes</b> 	<b>Application/Control No.</b> 10067296	<b>Applicant(s)/Patent Under Reexamination</b> AWAMOTO ET AL.
	<b>Examiner</b> Nano, Sargon N	<b>Art Unit</b> 2157

SEARCHED			
Class	Subclass	Date	Examiner
709	217, 219, 225, 227, 229, 246	6/8/2007	SN

SEARCH NOTES		
Search Notes	Date	Examiner
East (see attacehd report)	6/8/2007	SN
NPL Search	6/8/2007	SN
Consulted with Primary Examiner A. Salad	6/6/2007	SN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	217, 219, 246	6/8/2007	SN